

U.S. Department of Commerce, Patent and Trademark Office						Attorney Docket No.		Serial No.	
						P8900		10/774,990	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT						Applicant(s)			
(Use several sheets if necessary)						Matthew J. Amatangelo, et al.			
						Filing Date		Group	
						February 9, 2004		2123	

  

U.S. Patent Documents							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

  

Foreign Patent Documents								
		Document	Date	Country	Class	Subclass	Translation	
							Yes	No
	AL						<input type="checkbox"/>	<input type="checkbox"/>
	AM						<input type="checkbox"/>	<input type="checkbox"/>
	AN						<input type="checkbox"/>	<input type="checkbox"/>

  

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)		
8	AO	David Van Campenhout, Trevor Mudge, Kar�m A. Sakallah "Timing Verification of Sequential Domino Circuits," <i>Proc. TechCon 96</i> , September 1996
8	AP	Pawan Kulshreshtha, Robert Palermo, Mohammad Mortazavi, Cyrus Bamji, Hakan Yalcin "Transistor-Level Timing Analysis Using Embedded Simulation" Cadence Design Systems, Inc. <a href="http://www.sigda.org/Archives/ProceedingArchives/lccad/lccad2000/papers/2000/lccad00/pdf/files/08a_3.pdf">www.sigda.org/Archives/ProceedingArchives/lccad/lccad2000/papers/2000/lccad00/pdf/files/08a_3.pdf</a>
8	AR	Sumant Ramprasad, Ibrahim N. Hajj, Farid N. Najm "An Optimization Technique for Dual-Output Domino Logic," <i>Proceedings 1999 International Symposium on Low Power Electronics and Design</i> , p.258-260, August 16-17, 1999, San Diego, California
	AS	
	AT	

  

Examiner <u>Shamlihan Patel</u>	Date Considered <u>1/30/07</u>
---------------------------------	--------------------------------

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.